

Search Notes**Application/Control No.**

10/697,906

Examiner

Eric D. Bertram

Applicant(s)/Patent under Reexamination

CHIN ET AL.

Art Unit

3762

SEARCHED

Class	Subclass	Date	Examiner
607	17	9/27/2005	EDB
	18	9/27/2005	EDB
	119	9/27/2005	EDB
	127	9/28/2005	EDB
	129	9/28/2005	EDB
	130	9/28/2005	EDB
600	104-106	9/26/2006	EDB
	123, 129	9/26/2006	EDB
	154-158	9/26/2006	EDB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST notes, see attached	9/29/05	EDB
Inventor search on eDAN and PALM	9/26/2005	EDB
Consulted with Carl Layno (3762)	10/3/2005	EDB
Consulted with Mark Bockelman	7/25/2006	EDB